

Search Notes**Application/Control No.**

10/796,756

Examiner

JOHN J. LEE

**Applicant(s)/Patent under
Reexamination**

STEPHENS ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	522.69 523.67.11 435.1	2/26/2009	J.L
370	311,312	2/26/2009	J.L

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	2/26/2009	J.L